



#### 30V P-CHANNEL ENHANCEMENT MODE MOSFET PowerDI5060-8

### **Product Summary**

BV <sub>DSS</sub>	R <sub>DS(ON)</sub>	I <sub>D</sub> T <sub>C</sub> = +25°C
001/	$2.6m\Omega$ @ $V_{GS} = -10V$	-100A
-30V	$3.75 m\Omega$ @ $V_{GS} = -4.5V$	-70A

### **Description**

This new generation MOSFET is designed to minimize R<sub>DS(ON)</sub> and yet maintain superior switching performance. This device is ideal for use in notebook battery power management and load switch.

### **Applications**

Switch

PowerDI5060-8 (Type K)

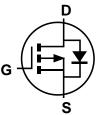


#### **Features**

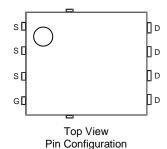
- 100% Unclamped Inductive Switch (UIS) Test in Production
- Thermally Efficient Package-Cooler Running Applications
- High Conversion Efficiency
- Low R<sub>DS(ON)</sub> Minimizes On State Losses
- <1.1mm Package Profile Ideal for Thin Applications
- Lead-Free Finish; RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

#### **Mechanical Data**

- Case: PowerDI<sup>®</sup>5060-8
- Case Material: Molded Plastic, "Green" Molding Compound;
   UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Finish Matte Tin Annealed over Copper Leadframe;
   Solderable per MIL-STD-202, Method 208 63
- Weight: 0.097 grams (Approximate)







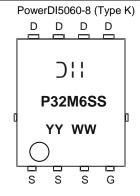
#### Ordering Information (Note 4)

Part Number	Case	Packaging
DMP32M6SPS-13	PowerDI5060-8 (Type K)	2,500 / Tape & Reel

Notes:

- 1. EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant. All applicable RoHS exemptions applied.
- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.

### **Marking Information**



☐ H = Manufacturer's Marking
P32M6SS = Product Type Marking Code
YYWW = Date Code Marking
YY = Last Two Digits of Year (ex: 19 = 2019)
WW = Week Code (01 to 53)



## **Maximum Ratings** (@ $T_A = +25^{\circ}C$ , unless otherwise specified.)

Characteristic				Value	Unit
Drain-Source Voltage			$V_{DSS}$	-30	V
Gate-Source Voltage			$V_{GSS}$	±20	V
Continuous Drain Current, V <sub>GS</sub> = -10V (Note 7) (Package Limited)	Steady State	$T_C = +25$ °C $T_C = +70$ °C	I <sub>D</sub>	-100 -70	А
Continuous Drain Current, V <sub>GS</sub> = -10V (Note 6)	t ≤ 10s	$T_A = +25$ °C $T_A = +70$ °C	I <sub>D</sub>	-37 -30	Α
Pulsed Drain Current (380µs Pulse, Duty Cycle = 1%)			I <sub>DM</sub>	-400	Α
Maximum Continuous Body Diode Forward Current (Note 6)			Is	-2.7	Α
Pulsed Body Diode Forward Current (380µs Pulse, Duty Cycle = 1%)			I <sub>SM</sub>	-400	Α
Avalanche Current, L = 0.1mH (Note 8)			I <sub>AS</sub>	-80	Α
Avalanche Energy, L = 0.1mH (Note 8)			E <sub>AS</sub>	250	mJ

#### **Thermal Characteristics**

Characteristic	Symbol	Value	Unit	
Total Power Dissipation (Note 5)		P <sub>D</sub>	1.3	W
Thermal Desistance, Junction to Ambient (Note 5)	Steady State	D	98	°C/W
Thermal Resistance, Junction to Ambient (Note 5)	t ≤ 10s	$R_{\theta JA}$	49	
Total Power Dissipation (Note 6)		$P_{D}$	2.3	W
Thermal Desistance, Junction to Ambient (Note C)	Steady State	Б.	54	°C/W
Thermal Resistance, Junction to Ambient (Note 6)	t ≤ 10s	$R_{\theta JA}$	27	
Thermal Resistance, Junction to Case (Note 7)		$R_{\theta JC}$	0.9	°C/W
Operating and Storage Temperature Range		$T_{J,}T_{STG}$	-55 to +150	°C

# **Electrical Characteristics** (@T<sub>A</sub> = +25°C, unless otherwise specified.)

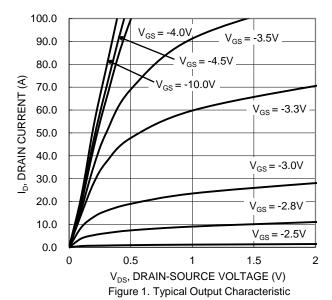
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 9)							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	-30	_	_	V	$V_{GS} = 0V, I_D = -250\mu A$	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	_	_	-1	μΑ	$V_{DS} = -24V, V_{GS} = 0V$	
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 9)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	-1.0	_	-2.5	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	
Static Drain-Source On-Resistance	В	_	1.8	2.6	mΩ	$V_{GS} = -10V, I_D = -20A$	
Static Drain-Source On-Resistance	R <sub>DS(ON)</sub>	_	2.4	3.75	11122	$V_{GS} = -4.5V, I_D = -20A$	
Diode Forward Voltage	V <sub>SD</sub>	_	-0.6	-1.2	V	$V_{GS} = 0V, I_{S} = -1A$	
DYNAMIC CHARACTERISTICS (Note 10)							
Input Capacitance	Ciss	_	8594	_	pF	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	
Output Capacitance	Coss	_	1491	_	pF	$V_{DS} = -15V, V_{GS} = 0V$ -f = 1MHz	
Reverse Transfer Capacitance	C <sub>rss</sub>	_	874	_	pF	1 = 1101112	
Gate Resistance	Rg	_	6.38	_	Ω	$V_{DS} = 0V$ , $V_{GS} = -15$ mV, $f = 1$ MHz	
Total Gate Charge (V <sub>GS</sub> = -4.5V)	Qg	_	75	_	nC		
Total Gate Charge (V <sub>GS</sub> = -10V)	$Q_g$	_	158	_	nC	\/ 45\/ L 25A	
Gate-Source Charge	Q <sub>gs</sub>	_	23.0	_	nC	$V_{DS} = -15V, I_D = -25A$	
Gate-Drain Charge	$Q_{gd}$	_	25.5	_	nC		
Turn-On Delay Time	t <sub>D(ON)</sub>	_	6.74	_	ns		
Turn-On Rise Time	t <sub>R</sub>	_	5.46	_	ns	$V_{DS} = -15V, V_{GS} = -10V,$	
Turn-Off Delay Time	t <sub>D(OFF)</sub>	_	227	_	ns	$R_{GS} = 2.7\Omega, I_{D} = -1A$	
Turn-Off Fall Time	t <sub>F</sub>	_	108	_	ns	]	
Reverse Recovery Time	t <sub>RR</sub>	_	37.4	_	ns	1 25A di/dt 400A/	
Reverse Recovery Charge	Q <sub>RR</sub>	_	36.8	_	nC	I <sub>F</sub> = -25A, di/dt = 100A/μs	

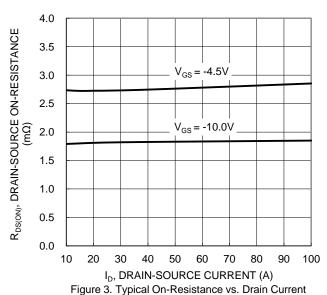
Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
 Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
 Thermal resistance from junction to soldering point (on the exposed drain pad).

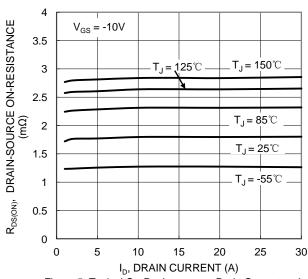
- 8.  $I_{AS}$  and  $E_{AS}$  ratings are based on low frequency and duty cycles to keep  $T_J$  = +25°C.
- 9. Short duration pulse test used to minimize self-heating effect.
- 10. Guaranteed by design. Not subject to product testing.



### DMP32M6SPS







and Gate Voltage

Figure 5. Typical On-Resistance vs. Drain Current and Junction Temperature

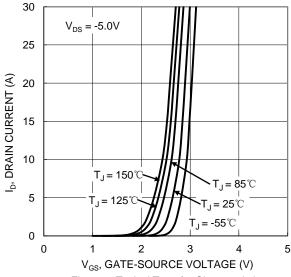
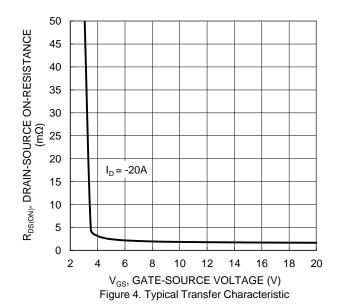


Figure 2. Typical Transfer Characteristic



2 R<sub>DS(ON)</sub>, DRAIN-SOURCE ON-RESISTANCE 1.8  $V_{GS} = -10V, I_D = -20A$ 1.6 (NORMALIZED) 1.2 1  $V_{GS} = -4.5V, I_{D} = -20A$ 8.0 0.6 0.4 -50 -25 0 25 50 75 100 125 150  $T_J$ , JUNCTION TEMPERATURE ( $^{\circ}$ )

Figure 6. On-Resistance Variation with Junction Temperature



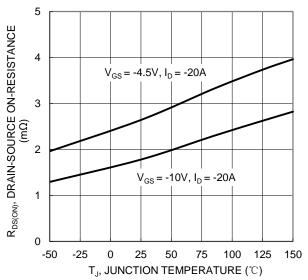


Figure 7. On-Resistance Variation with Junction Temperature

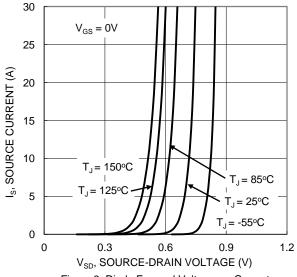


Figure 9. Diode Forward Voltage vs. Current

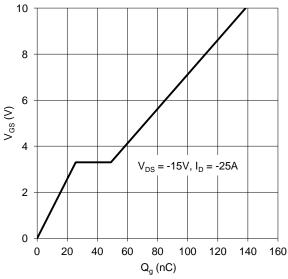


Figure 11. Gate Charge

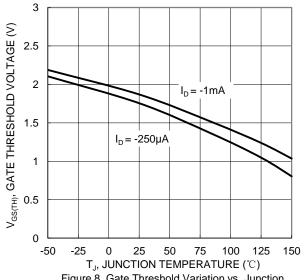
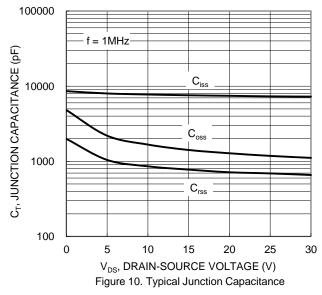


Figure 8. Gate Threshold Variation vs. Junction Temperature



1000 100 ID, DRAIN CURRENT (A) 10  $T_{J(Max)} = 150^{\circ}C$ = 100 ms $T_C = 25^{\circ}C$ Single Pulse DUT on Infinite Heatsink  $V_{GS} = -10V$ 0.1 0.1 10 100 V<sub>DS</sub>, DRAIN-SOURCE VOLTAGE (V)

Figure 12. SOA, Safe Operation Area



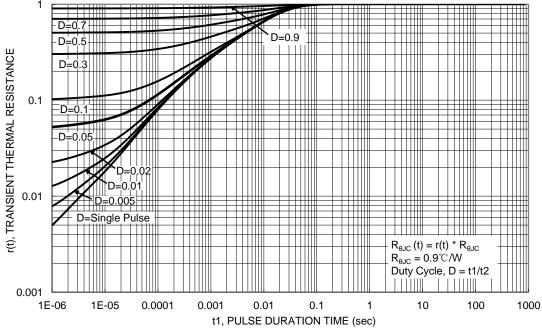


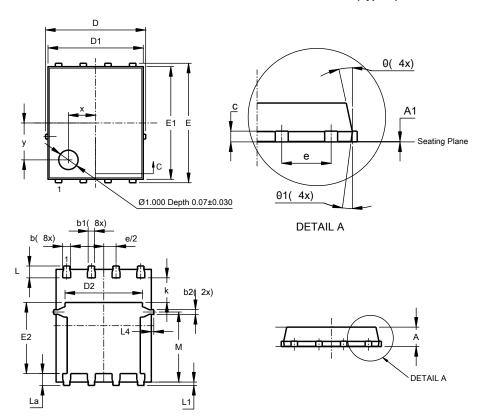
Figure 13. Transient Thermal Resistance



## **Package Outline Dimensions**

Please see http://www.diodes.com/package-outlines.html for the latest version.

#### PowerDI5060-8 (Type K)

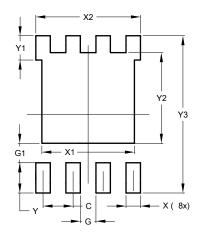


PowerDI5060-8 (Type K)					
Dim	Min	Max	Тур		
Α	0.90	1.10	1.00		
A1	0	0.05	0.02		
b	0.33	0.51	0.41		
b1	0.300	0.366	0.333		
b2	0.20	0.35	0.25		
С	0.23	0.33	0.277		
D	5.15 BSC				
D1	4.85	4.95	4.90		
D2	-	-	3.98		
Е	6	.15 BS0	)		
E1	5.75	5.85	5.80		
E2	3.56	3.725	3.66		
е	1	.27BSC	)		
k	-	-	1.27		
L	0.51	0.71	0.61		
La	0.51	0.675	0.61		
L1	0.05	0.20	0.175		
L4	-	-	0.125		
М	3.50	3.71	3.605		
Х	-	-	1.400		
у	-	-	1.900		
θ	10°	12°	11°		
θ1	6°	8°	7°		
All Dimensions in mm					

## **Suggested Pad Layout**

Please see http://www.diodes.com/package-outlines.html for the latest version.

#### PowerDI5060-8 (Type K)



Dimensions	Value (in mm)			
С	1.270			
G	0.660			
G1	0.820			
X	0.610			
X1	3.910			
X2	4.420			
Y	1.270			
Y1	1.020			
Y2	3.810			
Y3	6.610			

July 2019



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